NTD6414AN

N-Channel Power MOSFET 100 V, 32 A, 37 m Ω

Features

- Low R_{DS(on)}
- High Current Capability
- 100% Avalanche Tested
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Para	Symbol	Value	Unit		
Drain-to-Source Voltage			V _{DSS}	100	V
Gate-to-Source Voltage	ge – Conti	nuous	V _{GS}	±20	V
Continuous Drain	Steady State	T _C = 25°C	I _D	32	Α
Current R _{θJC}	Siale	T _C = 100°C		22	
Power Dissipation $R_{\theta JC}$	Steady State			100	W
Pulsed Drain Current	t _p	= 10 μs	I _{DM}	117	Α
Operating and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			I _S	32	Α
Single Pulse Drain-to-Source Avalanche Energy (V_{DD} = 50 Vdc, V_{GS} = 10 Vdc, $I_{L(pk)}$ = 32 A, L = 0.3 mH, R_G = 25 Ω)			E _{AS}	154	mJ
Lead Temperature for Soldering Purposes, 1/8" from Case for 10 Seconds			T _L	260	°C

THERMAL RESISTANCE RATINGS

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aSneet4U.com Parameter	Symbol	Max	Unit
Junction-to-Case (Drain) Steady State	$R_{\theta JC}$	1.5	°C/W
Junction-to-Ambient (Note 1)	$R_{\theta JA}$	37	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

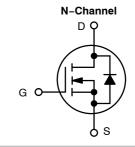
1. Surface mounted on FR4 board using 1 sq in pad size, (Cu Area 1.127 sq in [1 oz] including traces).



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V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX (Note 1)	
100 V	37 mΩ @ 10 V	32 A	



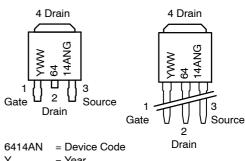


STYLE 2

IPAK CASE 369AA **CASE 369D**

MARKING DIAGRAM & PIN ASSIGNMENTS

STYLE 2



Υ = Year WW = Work Week G = Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_{.1} = 25°C unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	<u> </u>		•				
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		100			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				107		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _G s = 0 V.	T _J = 25°C			1.0	μΑ
		$V_{GS} = 0 \text{ V},$ $V_{DS} = 100 \text{ V}$	T _J = 125°C			100	1
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} =	±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	250 μΑ	2.0		4.0	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				8.3		mV/°C
Drain-to-Source On-Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D =	= 32 A		30	37	mΩ
Forward Transconductance	gFS	V _{GS} = 5.0 V, I _D :	= 10 A		18		S
CHARGES, CAPACITANCES AND GAT	E RESISTANO	CE					
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 25 V			1450		pF
Output Capacitance	C _{OSS}				230		
Reverse Transfer Capacitance	C _{RSS}				95		
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 10 V, V_{DS} = 80 V, I_{D} = 32 A			40		nC
Threshold Gate Charge	Q _{G(TH)}				1.7		
Gate-to-Source Charge	Q _{GS}				8.0		
Gate-to-Drain Charge	Q_{GD}				20		
Plateau Voltage	V _{GP}				5.9		V
Gate Resistance	R _G				1.9		Ω
SWITCHING CHARACTERISTICS (Note	∋ 4)						
Turn-On Delay Time	t _{d(on)}				11		ns
Rise Time	t _r	V _{GS} = 10 V, V _{DD}	= 80 V.		52		
Turn-Off Delay Time	t _{d(off)}	I _D = 32 A, R _G =	6.1 Ω		38		
Fall Time	t _f	1			48		
DRAIN4SOURCE DIODE CHARACTER	ISTICS	•	•		•	•	
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 \text{ V}, I_S = 32 \text{ A}$ $T_J = 25^{\circ}\text{C}$ $T_J = 125^{\circ}\text{C}$			0.87	1.2	V
					0.76		
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A}/\mu\text{s,}$ $I_{S} = 32 \text{ A}$			68		ns
Charge Time	T _a				51		1
Discharge Time	T _b				16		1
Reverse Recovery Charge	Q _{RR}				195		nC

Surface mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).
 Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

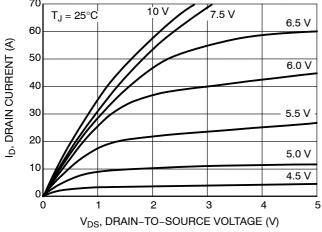


Figure 1. On-Region Characteristics

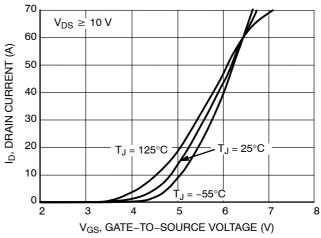


Figure 2. Transfer Characteristics

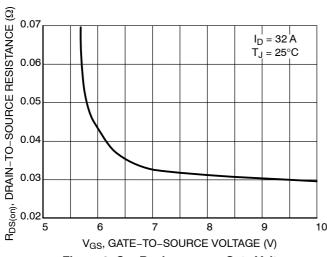


Figure 3. On–Region versus Gate Voltage www.DataSheet4U.com

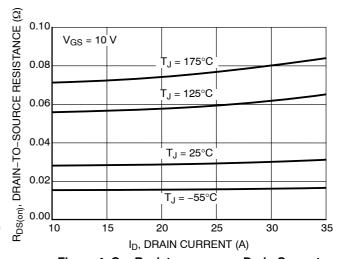


Figure 4. On-Resistance versus Drain Current and Gate Voltage

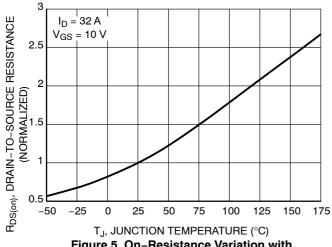


Figure 5. On–Resistance Variation with Temperature

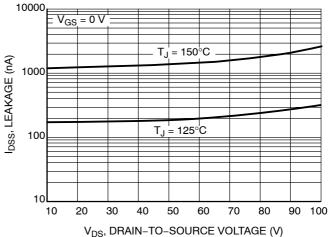
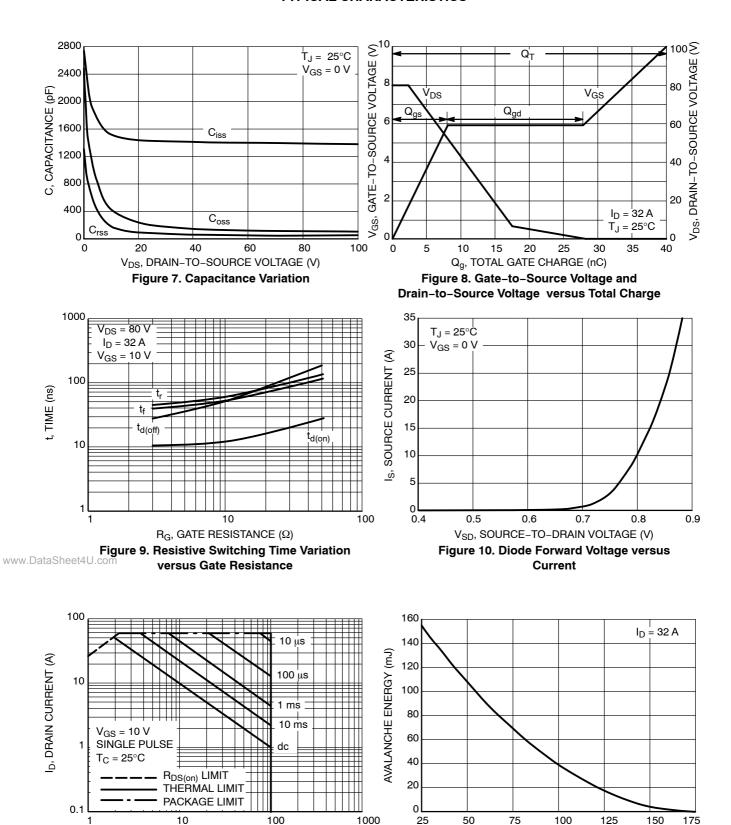


Figure 6. Drain-to-Source Leakage Current versus Voltage

TYPICAL CHARACTERISTICS



V_{DS}, DRAIN-TO-SOURCE VOLTAGE (V)

Figure 11. Maximum Rated Forward Biased
Safe Operating Area

T_J, STARTING JUNCTION TEMPERATURE

Figure 12. Maximum Avalanche Energy versus

Starting Junction Temperature

TYPICAL CHARACTERISTICS

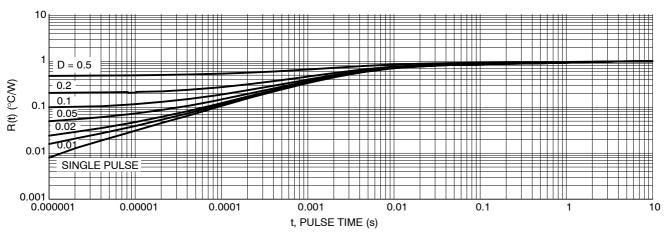


Figure 13. Thermal Response

ORDERING INFORMATION

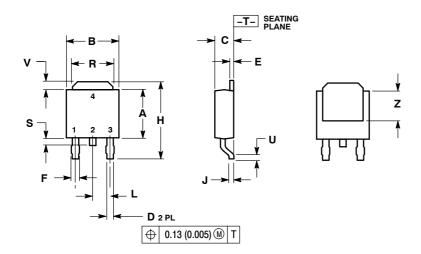
Device	Package	Shipping†
NTD6414ANT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NTD6414AN-1G	IPAK (Pb-Free)	75 Units / Rail

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

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PACKAGE DIMENSIONS

DPAK CASE 369AA-01 **ISSUE A**



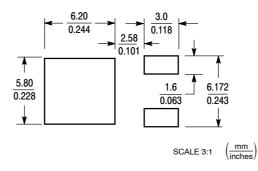
NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIM	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.22
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.025	0.035	0.63	0.89
E	0.018	0.024	0.46	0.61
F	0.030	0.045	0.77	1.14
Н	0.386	0.410	9.80	10.40
J	0.018	0.023	0.46	0.58
L	0.090	BSC	2.29	BSC
R	0.180	0.215	4.57	5.45
S	0.024	0.040	0.60	1.01
U	0.020		0.51	
٧	0.035	0.050	0.89	1.27
7	0.155	l	3 03	

- STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE
 - 4. DRAIN

SOLDERING FOOTPRINT*

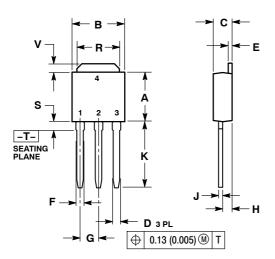


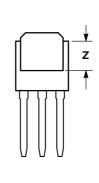
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^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

DPAK CASE 369D-01 **ISSUE B**





NOTES:

- DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIMETER	
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090	0.090 BSC		BSC
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
Κ	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

STYLE 2:

- PIN 1. GATE 2. DRAIN

 - 3. SOURCE DRAIN

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